

# MOSFET – Power, Single, N-Channel

40 V, 102 A, 3.3 m $\Omega$ 

## NTMYS3D5N04C

#### **Features**

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- LFPAK4 Package, Industry Standard
- These Devices are Pb-Free and are RoHS Compliant

#### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol	Parameter			Value	Unit
V <sub>DSS</sub>	Drain-to-Source Voltag	Drain-to-Source Voltage			V
V <sub>GS</sub>	Gate-to-Source Voltag	е		±20	V
I <sub>D</sub>	Continuous Drain		T <sub>C</sub> = 25°C	102	Α
	Current R <sub>θJC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C	72	
P <sub>D</sub>	Power Dissipation	State	T <sub>C</sub> = 25°C	68	W
	R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C	34	
I <sub>D</sub>	Continuous Drain		T <sub>A</sub> = 25°C	24	Α
	Current R <sub>θJA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C	17	
P <sub>D</sub>	Power Dissipation	State	T <sub>A</sub> = 25°C	3.6	W
	R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C	1.8	
I <sub>DM</sub>	Pulsed Drain Current	$T_A = 25^\circ$	°C, t <sub>p</sub> = 10 μs	554	Α
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range			-55 to +175	°C
I <sub>S</sub>	Source Current (Body Diode)			65	Α
E <sub>AS</sub>	Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 7.0 A)			215	mJ
TL	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

#### THERMAL RESISTANCE MAXIMUM RATINGS

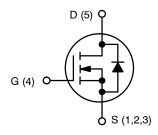
Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Junction-to-Case - Steady State	2.2	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State (Note 2)	39	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	3.3 m $\Omega$ @ 10 V	102 A



LFPAK4 CASE 760AB



**N-CHANNEL MOSFET** 

#### MARKING DIAGRAM



3D5N04C = Specific Device Code A = Assembly Location

WL =Wafer Lot
Y = Year
W = Work Week

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise specified)

Symbol	Parameter	Test Condition		Min	Тур	Max	Unit
OFF CHAR	ACTERISTICS			•		•	
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		40			V
V <sub>(BR)DSS</sub> / T <sub>J</sub>	Drain-to-Source Breakdown Voltage Temperature Coefficient				22		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0 V,	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 25°C			10	μΑ
		V <sub>DS</sub> = 40 V	T <sub>J</sub> = 125°C			100	
$I_{GSS}$	Gate-to-Source Leakage Current	V <sub>DS</sub> = 0 V, V <sub>G</sub>	<sub>S</sub> = 20 V			100	nA
ON CHARA	CTERISTICS (Note 6)						
ON CHARA	CTERISTICS (Note 6)						
V <sub>GS(TH)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{DS}$	) = 60 μΑ	2.5		3.5	V
V <sub>GS(TH)</sub> /T <sub>J</sub>	Threshold Temperature Coefficient				-7.8		mV/°C
R <sub>DS(on)</sub>	Drain-to-Source On Resistance	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 50 A		2.7	3.3	mΩ
9FS	Forward Transconductance	V <sub>DS</sub> =15 V, I <sub>I</sub>	<sub>O</sub> = 50 A		93		S
CHARGES,	CAPACITANCES & GATE RESISTANCE			•		•	
C <sub>ISS</sub>	Input Capacitance	V <sub>GS</sub> = 0 V, f = 1 MH	Iz, V <sub>DS</sub> = 25 V		1600		pF
C <sub>OSS</sub>	Output Capacitance				830		1
C <sub>RSS</sub>	Reverse Transfer Capacitance				28		1
Q <sub>G(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 2	20 V; I <sub>D</sub> = 50 A		23		nC
Q <sub>G(TH)</sub>	Threshold Gate Charge	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 2	20 V; I <sub>D</sub> = 50 A		5.1		1
Q <sub>GS</sub>	Gate-to-Source Charge				9.0		1
Q <sub>GD</sub>	Gate-to-Drain Charge				3.5		1
V <sub>GP</sub>	Plateau Voltage		1		5.3		V
SWITCHING	G CHARACTERISTICS (Note 7)	•		1		1	<u>.                                      </u>
t <sub>d(ON)</sub>	Turn-On Delay Time	V <sub>GS</sub> = 10 V, V <sub>E</sub>	<sub>OS</sub> = 20 V,		10		ns
t <sub>r</sub>	Rise Time	I <sub>D</sub> = 50 A, R <sub>G</sub>	= 2.5 Ω		47		1
t <sub>d(OFF)</sub>	Turn-Off Delay Time		<u>-</u>		19		1
t <sub>f</sub>	Fall Time				3.0		1
DRAIN-SO	URCE DIODE CHARACTERISTICS				•	•	-
V <sub>SD</sub>	Forward Diode Voltage	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.9	1.2	V
		I <sub>S</sub> = 50 A	T <sub>J</sub> = 125°C		0.78		1
t <sub>RR</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, dIS/dt	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/μs,		37		ns
t <sub>a</sub>	Charge Time	I <sub>S</sub> = 50 A			18		1
t <sub>b</sub>	Discharge Time	$\dashv$			19		1
Q <sub>RR</sub>	Reverse Recovery Charge	$\dashv$			23		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

5. Switching characteristics are independent of operating junction temperatures.

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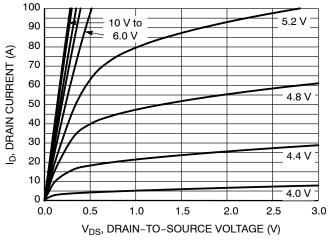
6. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%.

<sup>7.</sup> Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**

100

V<sub>DS</sub> = 10 V



90 VDS = 10 V

80 TJ = 25°C

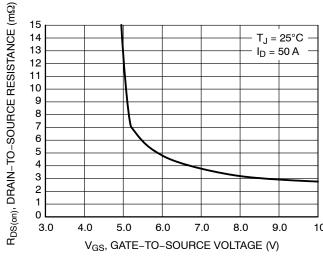
TJ = 25°C

TJ = -55°C

VGS, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



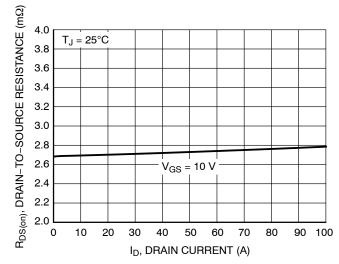
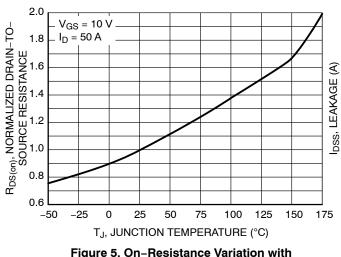


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



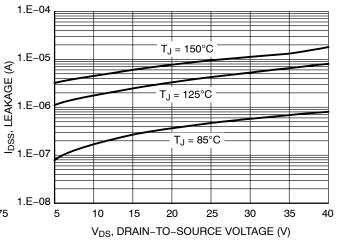
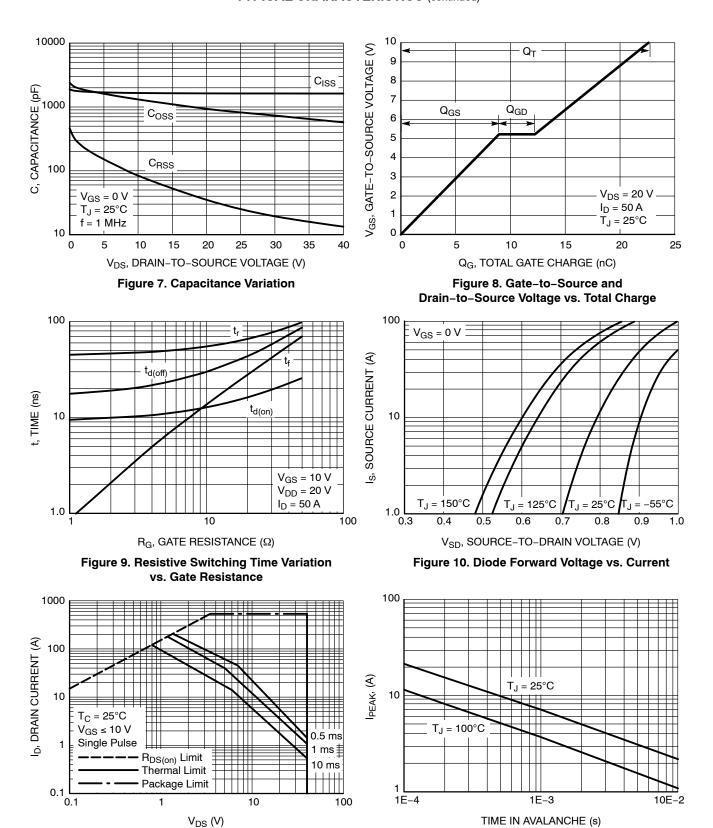


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

#### TYPICAL CHARACTERISTICS (continued)



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Figure 12. I<sub>PEAK</sub> vs. Time in Avalanche

Figure 11. Safe Operating Area

#### TYPICAL CHARACTERISTICS (continued)

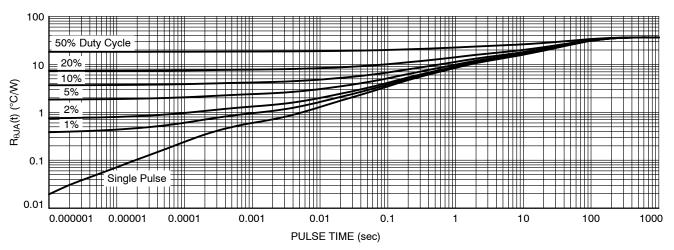


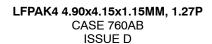
Figure 13. Thermal Characteristics

#### **DEVICE ORDERING INFORMATION**

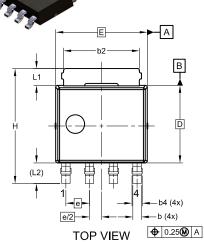
Device	Marking	Package	Shipping <sup>†</sup>
NTMYS3D5N04CTWG	3D5N04C	LFPAK4 (Pb-Free)	3,000 / Tape & Reel

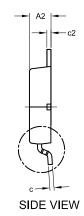
<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





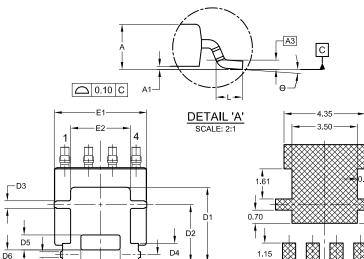
**DATE 22 MAY 2024** 





#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2018.
- CONTROLLING DIMENSION: MILLIMETERS.
- 3. DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.



0.70		-   1.27   -	
RECOM	IMENDI	ED LAND	PATTERN

1.30

1.06

0.60

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ONSEMI SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

# GENERIC MARKING DIAGRAM\*

**BOTTOM VIEW** 

(D8)

XXXXXX XXXXXX AWLYW XXXXXX = Specific Device Code A = Assembly Location

WL = Wafer Lot Y = Year W = Work Week

MILLIMETER					
DIM	MIN	NOM	MAX		
Α	1.10	1.20	1.30		
A1	0.00	0.08	0.15		
A2	1.10	1.15	1.20		
А3	C	).25 BSC	)		
b	0.40	0.45	0.50		
b2	3.80	4.10	4.40		
b4	0.45	0.55	0.65 0.25		
C	0.19	0.22	0.25		
c2	0.19	0.22	0.25		
D	4	4.15 BS0			
D1	3.80	4.00	4.20		
D2	3.00	3.10	3.20		
D3	0.30	0.40	0.50		
D4	0.90	1.00	1.10		
D5	0.70	0.80	0.90		
D6	0.55	0.65	0.75		
D7		0.31 REI			
D8	(	0.40 REI	F		
Е	4	4.90 BS	2		
E1	4.85	4.95	5.05		
E2	3.10	3.20	3.30		
E3	0.00	0.10	0.20		
E4	2.00	2.10	2.20		
е	1.27 BSC				
e/2	0.635 BSC				
e1	0.40 REF				
Н	6.00	6.15	6.30		
L	0.50	0.70	0.90		
L1	0.80	0.90	1.00		
L2	1.10 REF				
θ	0°	4°	8°		

### DOCUMENT NUMBER: 98

(D7)

98AON82777G

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**DESCRIPTION:** LFPAK4 4.90x4.15x1.15MM, 1.27P

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